

PODScan: Planar Drop Sizer

An Overview of the PODScan dropsizer



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Outline

- **SMD measurement Techniques**
- **Scattering and Extinction Tomography**
- **Mathematical Procedure**
- **Result and Discussion**
- **Conclusions and Future Works**



Single Point SMD

- PDPA – Velocity + Drop Size at the same time for a point
 - combine LDV and drop size capability
 - Planar measurement is time consuming.
- Diffraction
 - Malvern Instrument
 - Uses Mie theory to relate the scattering phase function to the drop size
 - Line of sight measurement, multiple scattering effect are significant for a dense spray due to high FOV optical arrangement

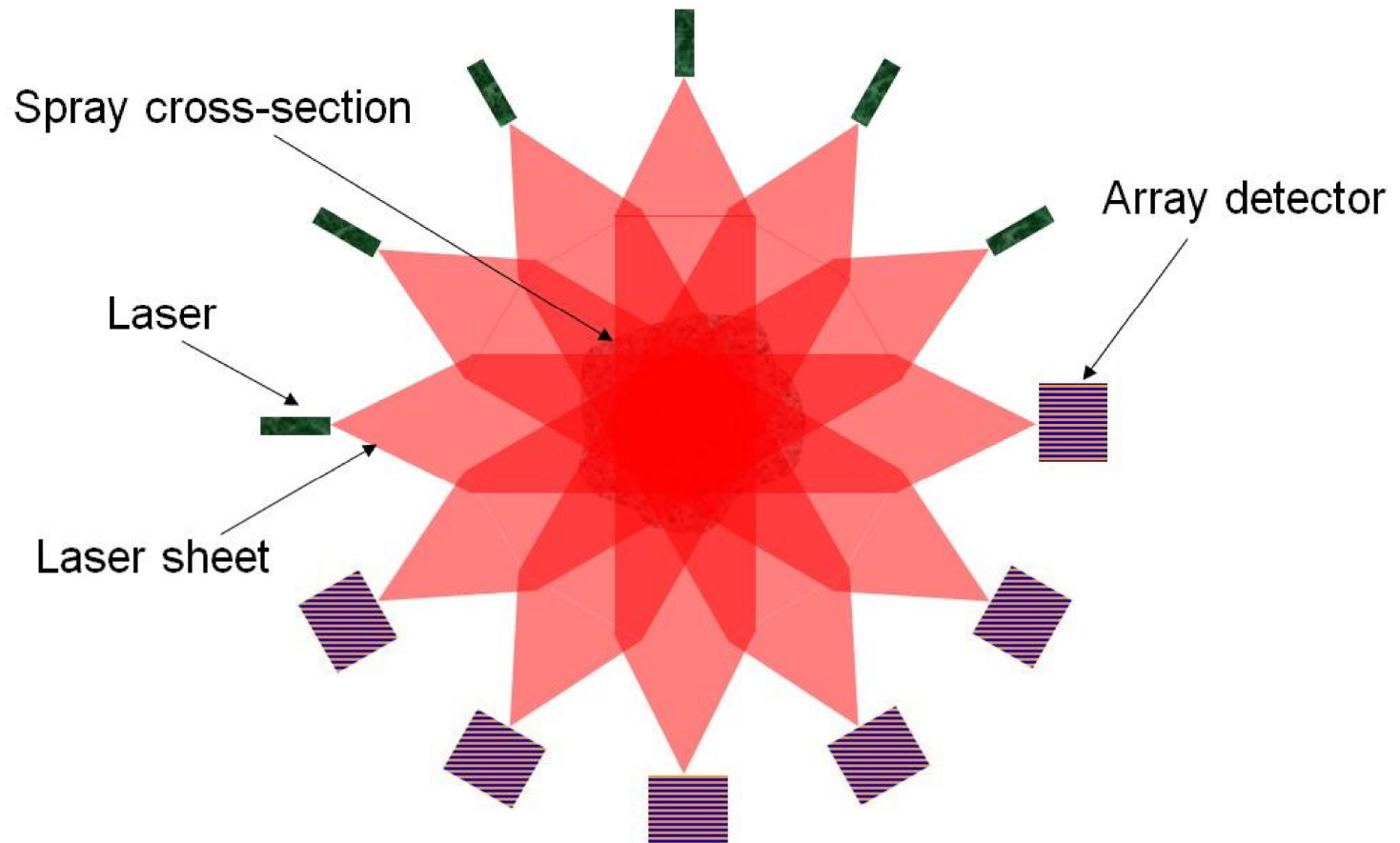
Planar SMD - LIF/MIE

- Yeh (1993), Sankar (1997) and Domann (2003), Commercially available system
- Fluorescence intensity is proportional to volume of droplet and scattering intensity is to the surface area of droplets

$$\frac{S_{LIF}}{S_{MIE}} = \frac{C_{LIF} \cdot \int D^3 P(D) dD}{C_{MIE} \cdot \int D^2 P(D) dD} = C \cdot SMD$$

- Fluorescence dye is necessary for water and liquid fuel, and calibration procedure is involved. For dense spray, the method suffers from multiple scattering effects.
- Multiple scattering effects are corrected with structured laser illumination (Mishra et. al.,2014)

Extinction Tomography for Local Surface Area





Extinction Tomography for Local Surface Area

- Path integrated extinction of laser sheets
- 6-Axis measurement with 512 linear array
- Local extinction coefficients obtained by statistical extinction tomography using MLE method
- For liquid sprays, the local extinction coefficients is equal to the surface area of the droplets
- No correction or calibration is required other than geometrical arrangement.
- No multiple scattering effects – applicable to near opaque spray



Scattering/Extinction Tomography

- Provide planar SMD distribution,
- Simple modification to extinction tomography system,
- Inherit benefit of extinction tomography – quantitative measurement, no correction is necessary.
- Minimal multiple scattering effects with Small FOV.
- No fluorescence dye is necessary, attractive in production setting.
- No calibration is necessary for scattering phase function as long optical efficiency of the sensors are uniform.
- Provides second order SMD (width of PDF) as well as first order (mean) SMD.

Radiative Transfer Equation with Scattering

$$I_{\lambda}^2 = \frac{S_{\lambda}}{\beta_{\lambda}} * (1 - \exp(-\beta_{\lambda} \cdot \Delta)) + I_{\lambda}^1 \cdot \exp(-\beta_{\lambda} \cdot \Delta)$$

$$S_{\lambda} = \sigma_{\lambda} \int_{\Omega} I_s \cdot \Phi(\theta) d\Omega$$

$$\beta_{\lambda} \cong \sigma_{\lambda}$$

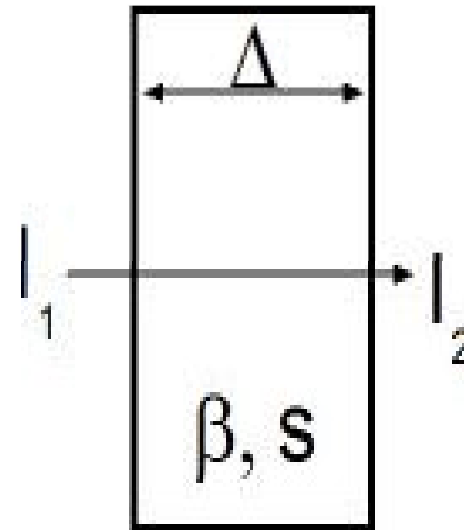
$\Phi(\theta)$ = scattering phase function

β_{λ} = extinction coefficient

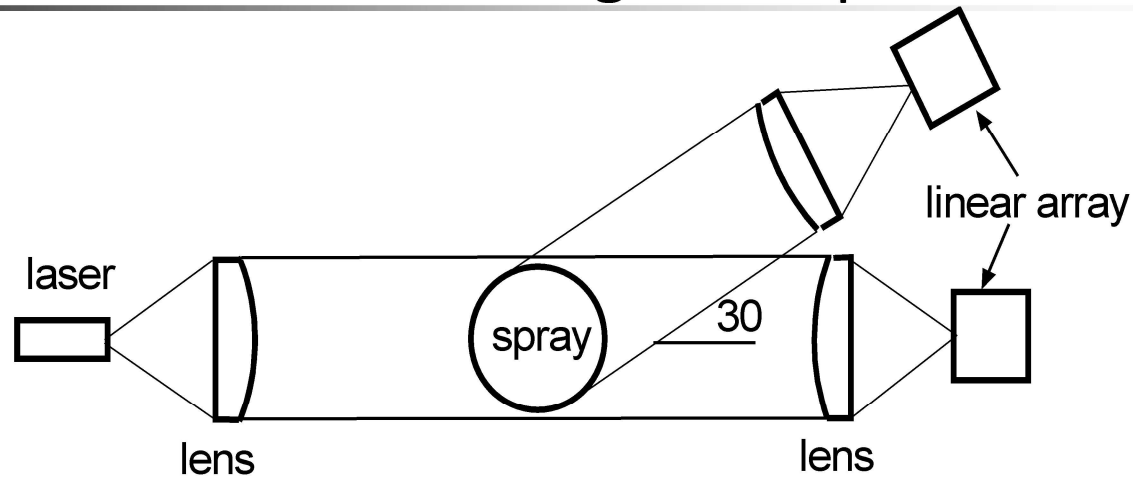
σ_{λ} = scattering coefficient

Δ = path length

S_{λ} = radiation source from scattering

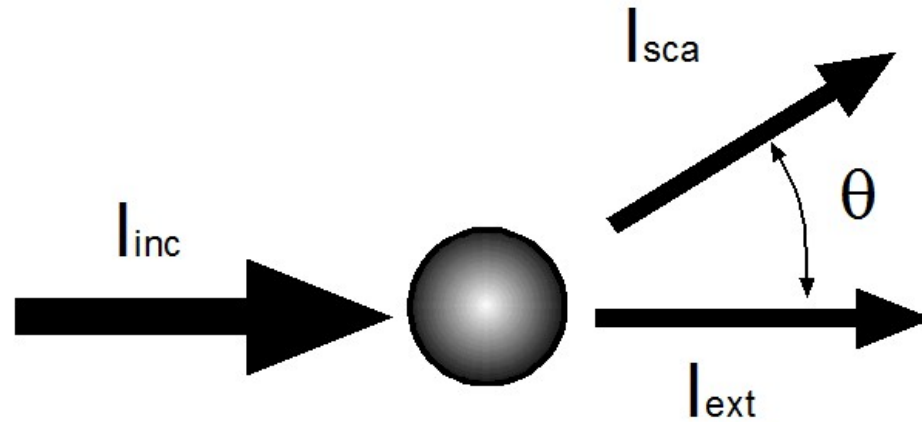


Geometrical Arrangement per Axis



- Inline axis measures the extinction caused by the drops
- 30 degree off axis measures the scattered intensity
- There are 6 axis of measurement of the scattering intensities and the extinction for the tomography system
- Optical system with a narrow aperture measures only in-plane light for both extinction and scattering (small FOV).

What is scattering phase function?

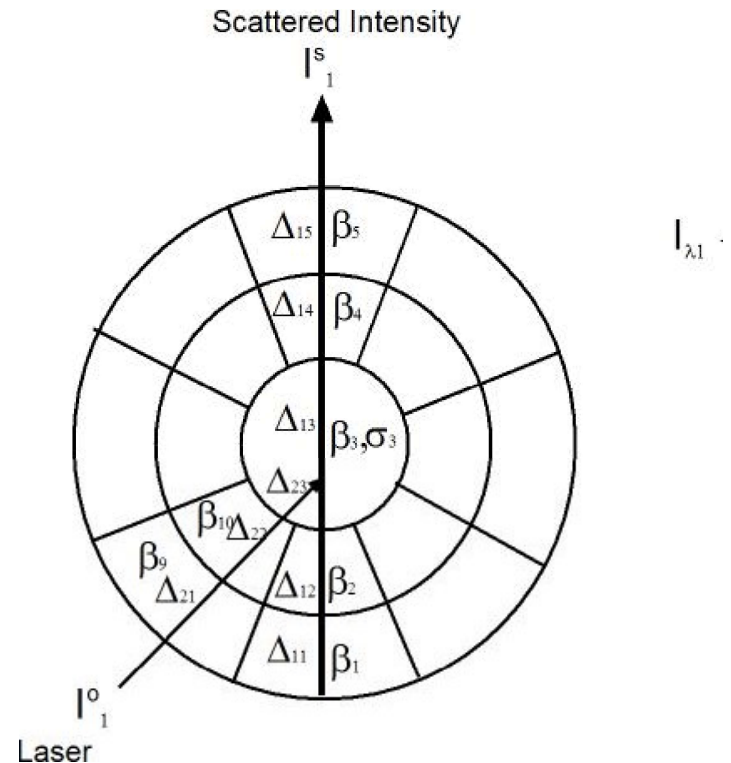


For spherical droplet

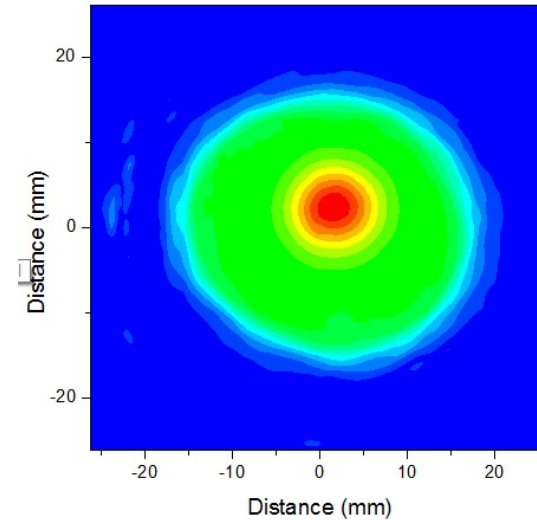
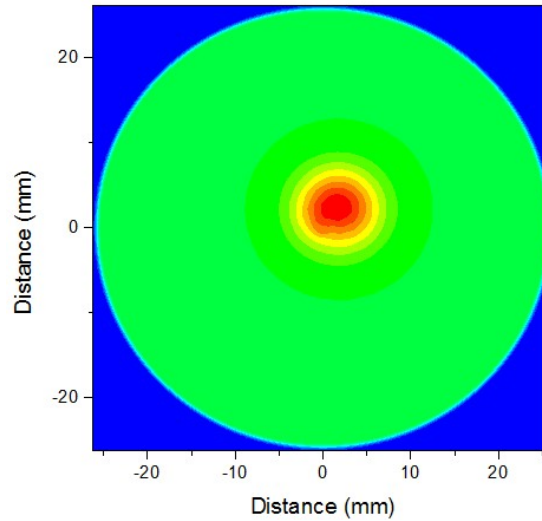
$$\Phi(\theta) = \frac{I_{sca}}{I_{inc}}$$

Scattering/Extinction Tomography

- Only single scattered light is accounted for in system
- Multiply scattered light is too small to be detected with the current optical arrangement.
- Scattered light at 30 degree is typically 1000 or 10000 less than incident light because of our narrow aperture for the sensor.
- All parallel lines of incident light contributes to a scattering measurement.



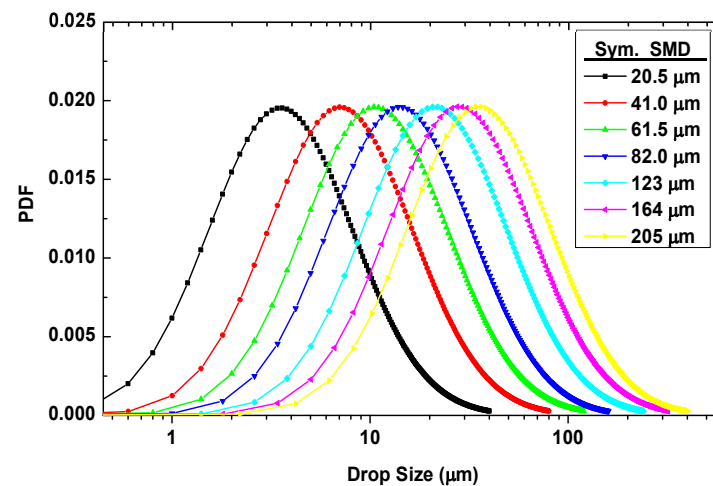
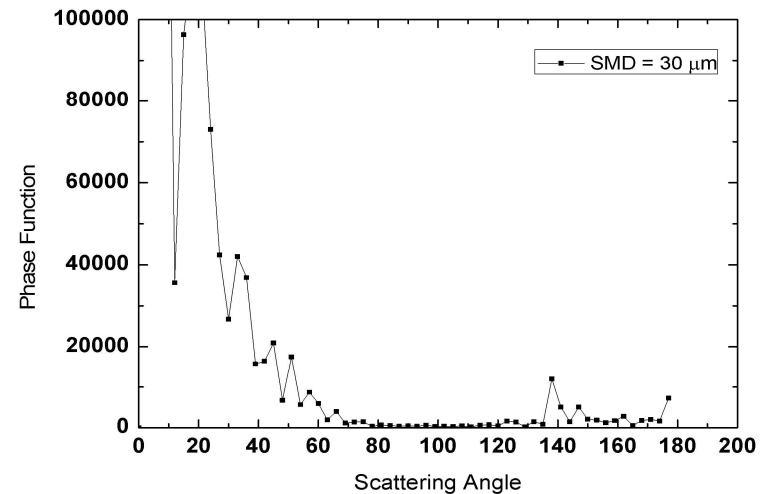
Numerical Validation for Tomography



- Forward Scattering Phase Function – Clipped Gaussian, Peak Value= 0.40.
- Reconstructed Scattering Phase Function – Peak Value= 0.393
- Recovery was excellent with given resolution of the tomography system

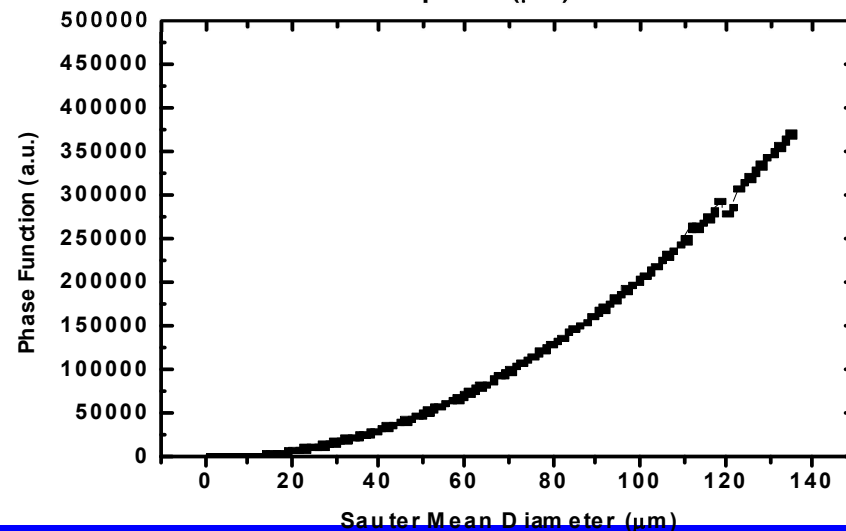
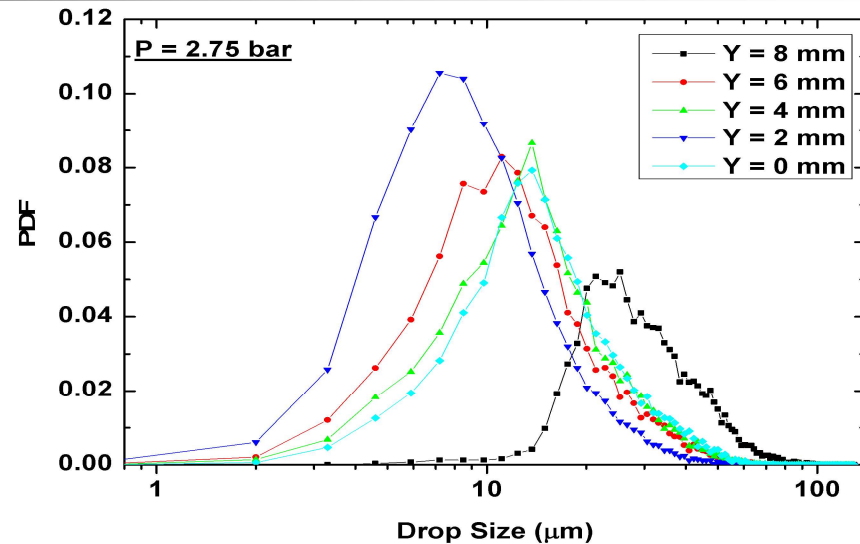
Scattering Phase Function and SMD

- Phase Function is directly related to the SMD if the droplet is spherical.
- Mie simulation will be used for the phase function.
- For the mono-disperse droplet, the phase function is extremely spiky.
- A log-normal distribution of drop size is used for the Mie simulation to smooth out.

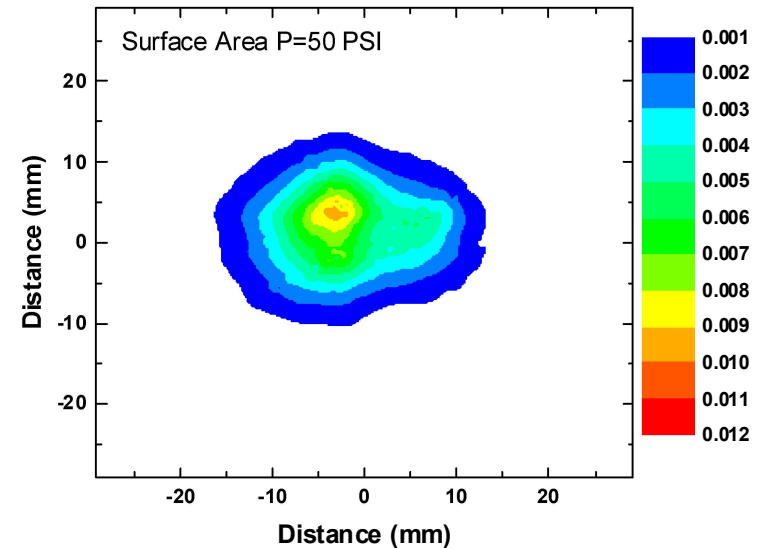
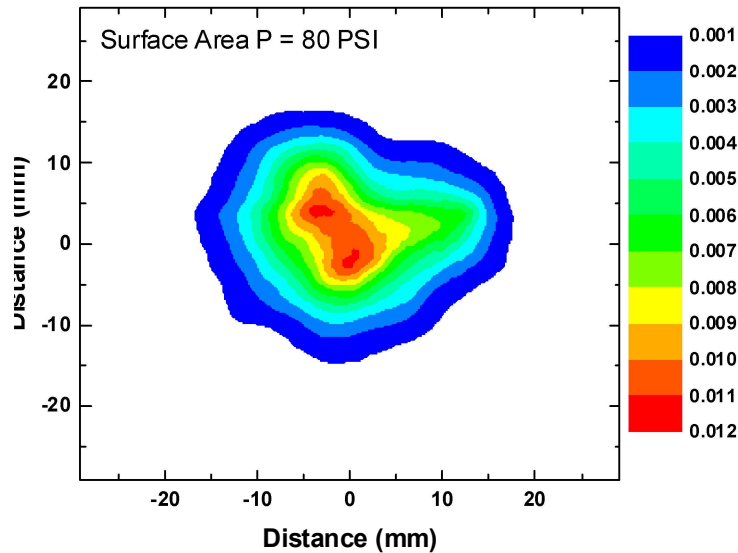


Scattering Phase Function and SMD

- PDF shape with PDPA measurement are all similar and shapes are log-normal distribution.
- Phase function is proportional to the SMD of spray.

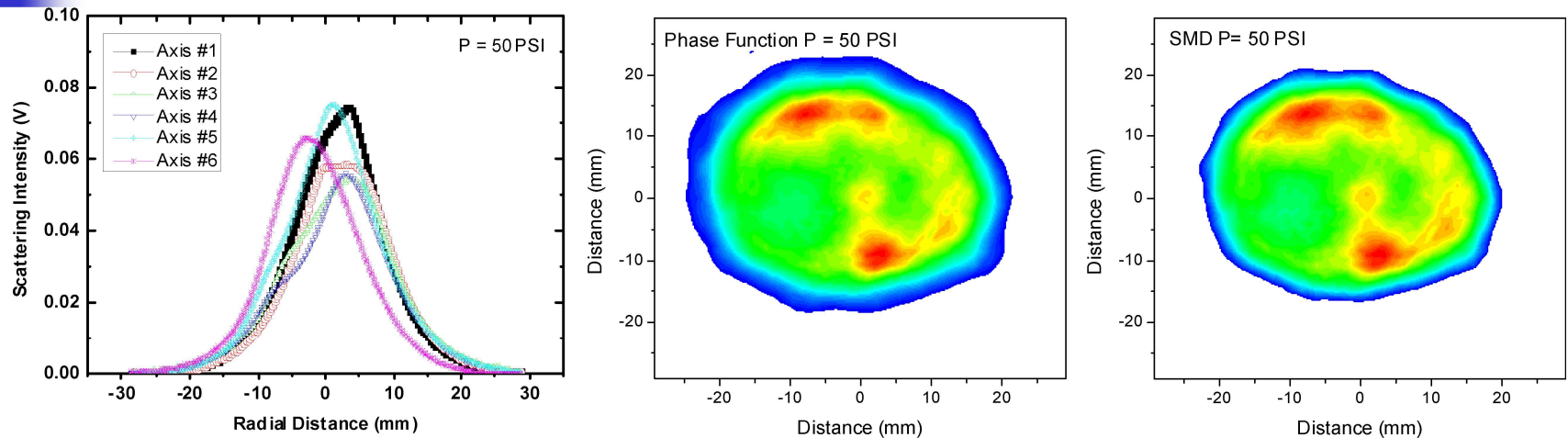


Results and Discussions



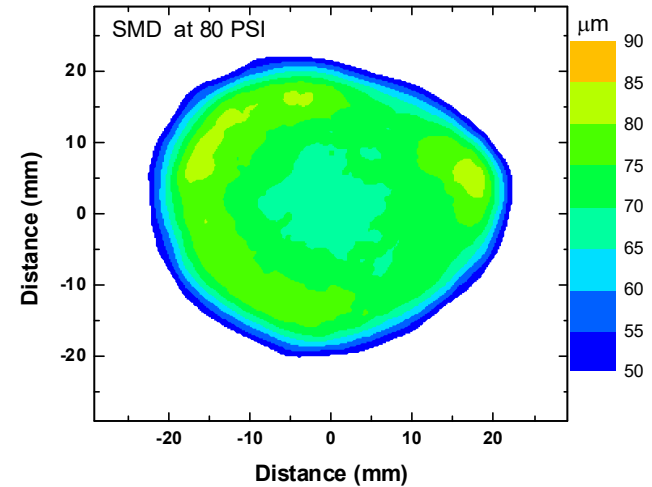
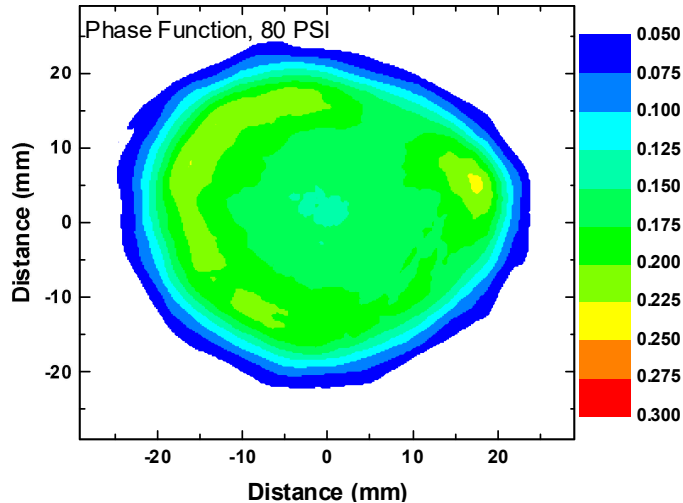
- Only 30 degree scattering signal is strong enough.
- Scattering signal is $\sim 1/10000$ smaller than extinction signal
- Neutral density filter were removed for the scattering measurement to increase sensitivity
- Peak extinction coefficient is at the center (high number density)

Deconvoluted SMD at P = 50 PSI



- The peak scattering intensity is very similar for all axis
- The high phase function at the periphery, which indicated the drop size are larger at the periphery
- SMD is almost linearly proportional to the Phase Function

Deconvoluted SMD at P = 80 PSI



- At higher pressures, drop sizes are more uniform
- SMD is almost linearly proportional to the Phase Function
- Measurements agree with PDI method



Conclusions

- A scattering/extinction tomography system was developed to estimate planar SMD distribution
- The scattering tomography system does not involve any calibration constants (other than accounting for the non-uniformity of sensors)
- The system is free of multiple scattering effects.
- Once the non-uniformity in optical efficiency of sensors are measured, the scattering phase function can be directly converted to SMD distribution.
- Second order SMD (width of PDF) as well as first order SMD (mean) and are available at the same time from the scattering/extinction tomography system.